

1 Description

2
3 Device for protecting electronic modules in a multi-voltage on-
4 board electrical system against short circuits

5
6 The invention relates to a device for protecting electronic
7 modules, in particular modules in electronic control systems,
8 data processing and transmission systems, low-power driver
9 circuits or CAN BUS transceivers, which are generally operated
10 at a supply voltage $V_{cc} = 5V$ to $10V$ and are disposed in a
11 control device, in other words ultimately control device
12 connections in a multi-voltage on-board electrical system, for
13 example a 42V/14V vehicle on-board electrical system against
14 short circuits to the highest voltage occurring in said on-
15 board electrical system.

16
17 The ever-increasing energy requirement of new electricity
18 consumers in motor vehicles and the need to reduce fuel
19 consumption, for example by assisting the drive train (stop and
20 go, boost and recovered braking) are driving forces in the move
21 from 14V on-board electrical systems to 42V on-board electrical
22 systems.

23
24 In order to be able to operate electronic modules and
25 components developed for a 14V on-board electrical system,
26 which include the electronic control system and data
27 transmission modules mentioned above, in the 42V on-board
28 electrical system, a 14V/42V on-board electrical system was
29 defined as an interim solution and the description which
30 follows refers to this.

31
32 The biggest obstacle to the continued use of electronic modules
33 and their components developed for the 14V on-board electrical

1 system - with the low on-board electrical system voltage - in
2 the 42V on-board electrical system - with the high on-board
3 electrical system voltage - is their inability to withstand
4 short circuits, for example to 50V in permanent mode or 60V in
5 transient mode.

6
7 In motor vehicles the lines to the modules mentioned are laid
8 in cable trees. Short circuits (flashovers, arcs) between these
9 lines can result for example due to said lines rubbing
10 together. The speed of the change in voltage in the event of a
11 short circuit from for example 5V or 14V to 42V is extremely
12 rapid, a matter of a few nanoseconds.

13
14 Protective circuits are therefore required, which can also be
15 used later in the 42V on-board electrical system.

16
17 Although previously a permanent ability to withstand short
18 circuits to 14V to 18V, depending on the customers'
19 requirements, and a transient ability to withstand short
20 circuits to 32V to 36V was adequate, in the 42V on-board
21 electrical system, as mentioned above, it is necessary to
22 withstand voltages for example to 50V in permanent mode and 60V
23 in transient mode.

24
25 A typical protective circuit according to the prior art in a
26 14V on-board electrical system for example for a
27 microcontroller μ C disposed in a control device ST is shown in
28 Figure 2. The input E of the microcontroller μ C is for example
29 shown as the input of an analogue-digital converter (ADC) (not
30 shown), to which the output signal of a sensor Se comprising a
31 changing resistance is supplied via a line L, said output
32 signal being digitised and further processed in the analogue-
33 digital converter (ADC) indicated by an arrow.

1
2 A stable supply voltage V_{cc} , generally $V_{cc} = 5V$, is supplied to
3 the microcontroller μC by means of a regulator (not shown) in
4 the control device ST.

5
6 The input E is assigned a protective structure integrated as
7 standard in the microcontroller μC and protecting against
8 electrostatic discharges, comprising a resistor R5 downstream
9 from the input E and two diodes D3 and D4, with the diode D3
10 disposed between the resistor R5 and the positive pole $+V_{cc}$ of
11 the supply voltage V_{CC} and conducting current in the direction
12 of the positive pole $+V_{cc}$, and with the diode D4 disposed
13 between the negative pole $-V_{cc}$ of the supply voltage V_{cc}
14 (ground potential GND of the control device ST) and the
15 resistor R5 and conducting current in the direction of the
16 resistor R5.

17
18 Two resistors R6 and R7, which are parallel to the diodes D3
19 and D4, represent parasitic leakage resistances. Because of the
20 high temperatures of $> 100^{\circ}C$ occurring during operation and the
21 temperature dependency of the leakage currents in
22 semiconductors these values can reach up to $1\mu A$. This
23 corresponds to a leakage resistance R6, R7 of approximately
24 $2.5M\Omega$ each.

25
26 Disposed between the sensor S and the positive pole $+V_{cc}$ in the
27 control device but outside the microcontroller μC is a resistor
28 R1, which together with the internal resistance R_{sens} of the
29 sensor S forms a voltage divider, which is supplied with the
30 supply voltage V_{cc} .

31
32 Disposed between the pick-off of this voltage divider and the
33 input E of the microcontroller μC is a protective resistor R2.

1 The divider voltage of the voltage divider $R1/R_{sens}$ is present
2 at the input E of the microcontroller μC , across the protective
3 resistor $R2$. It is a measure of the internal resistance of the
4 sensor.

5
6 The protective resistor $R2$ should be dimensioned such that
7 - the error caused by the parasitic leakage resistances $R6$, $R7$
8 of the input protection circuit is small and
9 - with an external maximum voltage in the event of an error V_{in}
10 = V_{bat} , the current flowing through the diode $D3$ is limited to
11 an acceptable level, for example $< 5mA$.

12 In the 14V on-board electrical system it is however no longer
13 possible to satisfy both requirements in the event of an
14 increase from 14V to 42V:

15 - if the protective resistor $R2$ is so large that the current
16 flowing through the diode $D3$ remains acceptably small, the
17 voltage errors caused by the leakage currents flowing through
18 the resistors $R6$, $R7$ become unacceptably large;
19 - if the value of the protective resistor $R2$ is left unchanged,
20 the current that is now increased threefold (due to 14V \rightarrow 42V)
21 will damage or destroy the input structure of the
22 microcontroller μC in the event of a short circuit to 42V.

23
24 This known protective circuit is therefore not protected
25 against a short circuit to 42V.

26
27 An overvoltage protection circuit, in particular for the inputs
28 of integrated circuits, is known from DE 197 28 783 A1, with an
29 overvoltage identification device, which, if an overvoltage
30 occurs on the input line, activates a transistor connected in
31 series to this input line and shown as a MOS field effect
32 transistor, which then brings about a high-resistance break in
33 this input line. In normal conditions this MOS field effect

1 transistor (hereafter referred to as MOSFET) represents a low-
2 resistance line in both directions.

3
4 The transistor is located with its drain source path in the
5 line to be protected. Between the source connection and the
6 gate connection of said transistor is a Zener diode, which
7 limits the gate source voltage to a predefined value and
8 between the gate connection and the positive pole of the on-
9 board electrical system voltage is a gate resistor.

10
11 This circuit is based on the principle of identifying an
12 overvoltage with subsequent disconnection of the in-phase
13 transistor. However in principle voltage identification is
14 associated with a delay time.

15
16 If an overvoltage now occurs in the form of a rapid voltage
17 change (e.g. short circuit due to voltage flashover to the
18 higher on-board electrical system voltage 42V), the voltage
19 suddenly increases at the nodes to be protected until the end
20 of the delay time plus the disconnection time of the in-phase
21 transistor. The speed of the voltage change in the event of a
22 short circuit to 42V is however extremely rapid, as mentioned
23 above.

24
25 With such rapid voltage changes, disconnection of the in-phase
26 transistor - due to the delays associated in principle - takes
27 place only after the high voltage is already present at the
28 nodes to be protected. This is also described in the said DE
29 197 28 783 A1, in that "only small switching peaks occur
30 respectively at the start and end of each of the overvoltage
31 pulses" (column 4, lines 62 to 65).

32

1 A circuit operating according to the same principle is known
2 from DE 3425235 C1.

3
4 Such rapid voltage changes cause the circuits described in the
5 two documents to fail in principle and they are therefore
6 unsuitable for use in the twin-voltage on-board electrical
7 system or in the single voltage on-board electrical system with
8 the higher on-board electrical system voltage,

9
10 The switching process can - depending on the design - take
11 between several 100 ns and several μ s. Destruction of the
12 components to be protected cannot be excluded.

13
14 The object of the invention is to create a simple device for
15 protecting electronic modules used in a 14V on-board electrical
16 system and disposed in a control device, i.e. therefore the
17 control device inputs and outputs, such that these modules can
18 also be protected reliably against short circuits occurring in
19 a 42V on-board electrical system.

20
21 This object is achieved according to the invention by a device
22 according to the features of claim 1.

23
24 Advantageous developments of the invention will emerge from the
25 subclaims.

26
27 Exemplary embodiments of the invention are described in more
28 detail below with reference to a schematic drawing, in which:

29
30 Figure 1 shows the circuit of a claimed device for protecting
31 electronic modules used in the 14V on-board electrical system
32 against short circuits in a 42V on-board electrical system,

1 Figure 2 shows a known protective circuit for an input of a
2 microcontroller in a 14V on-board electrical system,
3 Figure 3 shows an exemplary embodiment of the claimed
4 protective circuit for a low-power driver circuit and
5 Figure 4 shows an exemplary embodiment of the claimed
6 protective circuit for a CAN bus transceiver.

7
8 The invention does not use overvoltage identification devices
9 with subsequent disconnection of the in-phase transistor,
10 rather it is based on the principle of limiting the current in
11 the in-phase transistor using its cut-off voltage.

12
13 Figure 1 shows the circuit of a claimed protective circuit Ss
14 disposed in a control device ST for a microcontroller μ C known
15 from Figure 2 against short circuits in a 42V on-board
16 electrical system, said circuit being inserted between the
17 protective resistor R2 and the line L (the control device
18 connection A). In addition to the circuit shown in Figure 2,
19 Figure 1 also shows the 12V battery Bat1 of the on-board
20 electrical system with the low on-board voltage present in the
21 14V/42V on-board electrical system, while the voltage source of
22 the on-board electrical system with the high on-board voltage
23 is not shown.

24
25 The voltage arrow also shown in Figure 1 indicates the voltage
26 V_{in} of a sensor Se, which can also be the short-circuit voltage
27 to the 42V on-board electrical system with maximum 60V. This
28 voltage V_{in} forms the input voltage for the control device ST,
29 the value of which is transmitted to the control device ST from
30 the sensor Se via the line L.

31
32 The protective circuit Ss comprises a circuit set up around a
33 transistor T1, as known from DE 197 28 783 A1. In the case of

1 positive input voltages, this transistor T1 is preferably an N-
2 channel low-power MOSFET (Field Effect Transistor), the drain
3 connection D of which is connected via the control device
4 connection A (the line L) to the sensor Se and the source
5 connection S of which is connected to the protective resistor
6 R2.

7
8 Disposed between the gate connection G of the transistor T1 and
9 the positive pole +Vbat1 of the 12V battery Bat1 in the known
10 manner is the gate resistor Rv and disposed between the gate
11 connection G and the source connection S of the transistor T1
12 is a Zener diode operating as a limiter diode D1, the breakdown
13 voltage Vz of which is selected as for example $V_z = 18V$, such
14 that it is not conductive in normal operation ($V_z > V_{bat1}$) but
15 is conductive just before the maximum permitted gate source
16 voltage Vgs of the transistor T1 is reached, e.g. $V_{gs} = 20V$.

17
18 According to the invention a diode D2 is connected parallel to
19 the gate resistor Rv, said diode conducting current in the
20 direction from the gateway connection G to the positive pole
21 +Vbat1 of the battery Bat1.

22
23 This diode D2 limits the gate voltage Vg of the transistor T1
24 to a value $V_g = V_{bat1} + V_d$, i.e. to a value of the sum of the
25 low on-board electrical system voltage Vbat1 plus the
26 conducting state voltage Vd of the diode D2.

27
28 In the case of negative input voltages, the transistor T1 would
29 have to be a P-channel MOSFET, with all voltages, even the
30 processor voltage supply, then having to be reversed. A MOSFET
31 is thus advantageous, because it does not require control
32 current at the operating point. In the case of bipolar
33 transistors, with which the circuit would in principle also

1 function, the base current could impede the measuring function
2 as an additional error current. It is assumed below that the
3 transistor T1 is an N-channel MOSFET and the input voltages are
4 positive.

5
6 In the signal path from the sensor Se to the input E of the
7 microcontroller are just the low-resistance protective resistor
8 R2 and the comparatively low saturation resistance of the
9 transistor T1, for example 5Ω . The sensor signal is thereby
10 only influenced to a minimal degree.

11
12 In normal operation $0V < V_{in} < V_{cc}$ the transistor T1 is
13 conductive, as its gate voltage determined across the gate
14 resistor Rv is 14V and the gate source voltage Vgs at the
15 transistor T1 is significantly greater than its threshold
16 voltage Vth (for example $V_{th} = 3V$).

17
18 Investigation of errors occurring:

- 19
20 a) in the event of a short circuit to ground potential GND
21 ($V_{in} = 0V$), the voltage at the input E is also 0V and the
22 protective circuit Ss operates normally.
- 23 b) in the event of a short circuit to 14V (V_{bat1}) active at
24 the device connection A, the source voltage Vs of the
25 transistor T1 increases to a value $V_s = V_{bat1} - V_{th}$, in
26 other words to a value $V_s < V_{bat1}$. The transistor T1 is
27 now in the cut-off range. The current through the diode
28 D3 is limited by the protective resistor R2 to a
29 predefined permitted value.
- 30 c) in the event of negative transient voltages (for example
31 ISO test pulses) active at the device connection A, the
32 transistor T1 becomes conductive, with its gate source
33 voltage Vgs now being limited by the Zener diode D1. The

1 gate resistor R_v limits the current flow through the
2 Zener diode $D1$ to a tolerable value. The protective
3 resistor $R2$ limits the current flow through the diode $D4$
4 of the protective structure of the microcontroller μC .

5 d) in the event of a short circuit to the 42V on-board
6 electrical system active at the device connection A, the
7 input voltage V_{in} increases drastically - up to maximum
8 60V. The source voltage V_s of the transistor $T1$ will
9 increase in the event of a short circuit to 14V to a
10 value $V_s = V_{bat1} - V_{th}$, i.e. a value $V_s < V_{bat1}$. As the
11 transistor $T1$ is now in the cut-off range, the total
12 voltage difference drops there to the input voltage V_{in} .
13 The drain source voltage V_{ds} of the transistor $T1$ becomes
14 $V_{ds} = V_{in} - (V_{bat} - V_{th})$. The power loss $P(T1)$ resulting
15 at the transistor $T1$ is thereby determined by the voltage
16 difference V_{ds} and the current $I(R2)$ flowing through the
17 protective resistor $R2$: $P(T1) = V_{ds} \cdot I(R2)$. The peak value
18 occurring with transient voltages of 60V is $< 100mW$, the
19 effective value being around 60mW, which can be managed
20 easily using a standard housing for the transistor $T1$.

21
22 If the input voltage V_{in} increases to values $> V_{bat1}$, the gate
23 source voltage V_{gs} drops from 14V for example to the threshold
24 voltage V_{th} , for example $V_{th} = 3V$. The gate capacities of the
25 transistor $T1$ must thereby be transferred. With very rapid
26 transient voltages V_{in} an increased gate current of $I_g > 10mA$
27 is required in the short term in the event of a short circuit.

28
29 If this gate current were to flow exclusively across the gate
30 resistor $R_v = 10k\Omega$, it would cause a major voltage drop. The
31 gate voltage would increase to values $> 60V$ for a short time,
32 which would result in a short-term, significantly larger

1 current flow through the diode D3, which could damage or
2 destroy this.

3
4 As the diode D2 parallel to the gate resistor R_v is in this
5 case operated in the current conducting direction, it limits
6 the gate voltage V_g of the transistor T1 to a value $V_{bat1} + V_d$,
7 where V_d is the conducting state voltage of the diode D2.

8
9 The protective circuit thereby carries out its function in the
10 event of an error both in the 14V on-board electrical system
11 (low on-board voltage) and in the 42V on-board electrical
12 system (high on-board voltage) up to the point of rapid
13 transient changes in the input voltage V_{in} .

14
15 Figure 3 shows an exemplary embodiment of the claimed
16 protective circuit for a low-power driver circuit. A consumer
17 RL supplied by the 14V on-board electrical system, for example
18 a light-emitting diode of a warning light, is switched on and
19 off by means of a switching transistor T2.

20
21 The consumer RL is connected on the one hand to the positive
22 pole of the battery Bat1 and on the other hand via the line L
23 and the switching transistor T2 and a protective resistor R_s to
24 the negative pole GND of the battery Bat1. The switching
25 transistor T2 can generally be part of an integrated circuit
26 configured as a gang switch.

27
28 A short circuit to 42V without the claimed protective circuit
29 would destroy the switching transistor T2.

30
31 To prevent this, the protective circuit Ss known from Figure 1
32 is inserted into this configuration in the control device ST
33 between the transistor T2 and line L, such that the drain

1 connection D of the transistor T1 is connected via the control
2 device connection A and line L to the consumer RL and the
3 source connection S is connected to the switching transistor
4 and such that the point of connection between the gate resistor
5 Rv and the diode D2 is connected to the positive pole of the
6 battery Bat1.

7
8 The function of the protective circuit is the same as already
9 set out in the description of Figure 1.

10
11 Figure 4 finally shows a basic circuit diagram of a CAN bus
12 transceiver C-T disposed in the control device ST with the
13 claimed protective circuit against short circuits to 42V. The
14 transceiver C-T comprises a transmitter TM (transmit module)
15 and a receiver RC (receive module) in the known manner.

16
17 A suitable transceiver C-T for a high-speed version is for
18 example a Philips PCA82C250, the data for which can be found in
19 the data sheet "Philips semiconductors PCA82C250 CAN controller
20 interface, Product specification, 13 January 2000".

21
22 A high-speed CAN BUS generally has two differentially operated
23 lines CAN_HI and CAN_LO, the voltages of which are generally
24 $2.5V + 1V$ and $2.5V - 1V$.

25
26 Each of the two bus lines CAN_HI and CAN_LO is equipped with
27 its own

- 28 - protective circuit Ssa disposed in the control device ST:
29 between the bus line CAN_HI or control device connection A1 and
30 the connection E1 of the transmitter Tm (Ssa) and
- 31 - protective circuit Ssb disposed in the control device ST:
32 between the bus line CAN_LO or control device connection A2 and
33 the connection E2 of the receiver Rc.

1 In normal operation the protective circuits do not influence
2 the transmitter and receiver functions due to the low
3 saturation resistances of T1a and T1b. The voltage at the
4 transceiver C-T is only limited to a - permitted - value $V_{bat} -$
5 V_{th} in the event of a short circuit to 42V.

6
7 The function of the protective circuits Ssa and Ssb is the same
8 as already set out in the description of Figure 1.

9
10 The claimed protective circuit is significantly simpler than
11 the circuit known from DE 197 28 783 A1 and has significantly
12 fewer components.

13
14 It is suitable

15 - for protecting analogue and digital control device inputs of
16 electronic control system modules and data transmission modules
17 (data interfaces), as well as low-power driver circuits or CAN
18 BUS transceivers, which are operated at a supply voltage of V_{cc}
19 = 5V to 10V for example and are generally disposed in a control
20 device;

21 - it protects the connections (control device inputs and
22 outputs) reliably, even in the continued presence of high,
23 positive overvoltages; even rapid positive transients such as a
24 short circuit to 60V are not allowed through and are therefore
25 reliably managed and negative transients (e.g. ISO test pulses)
26 are tolerated;

27 - it is intrinsically safe and can be implemented economically
28 and simply with standard components;

29 - its circuit design is suitable for integration in an ASIC,
30 which can also be used later in the 42V single voltage on-board
31 electrical system;

32 - in normal operation it has no significant influence on the
33 accuracy of the capture of measured values;

1 - in normal operation it does not influence the data
2 transmission function.

3

4